

MOS FIELD EFFECT TRANSISTOR 2SK3484

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3484 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

· Low on-state resistance

 $R_{DS(on)1}$ = 125 $m\Omega$ MAX. (VGS = 10 V, ID = 8 A)

 $R_{DS(on)2} = 148 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, ID} = 8 \text{ A)}$

- Low Ciss: Ciss = 900 pF TYP.
- · Built-in gate protection diode
- TO-251/TO-252 package

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3484	TO-251		
2SK3484-Z	TO-252		

(TO-251)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vss = 0 V)	VDSS	100	V
Gate to Source Voltage (Vps = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	I _{D(DC)}	±16	Α
Drain Current (pulse) Note1	D(pulse)	±22	Α
Total Power Dissipation (Tc = 25°C)	P _{T1}	30	W
Total Power Dissipation (T _A = 25°C)	P _{T2}	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	IAS	10	Α
Single Avalanche Energy Note2	Eas	10	mJ

(TO-252



Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting Tch = 25°C, VDD = 50 V, RG = 25 Ω , VGS = 20 \rightarrow 0 V

THERMAL RESISTANCE

Channel to Case Thermal Resistance Rth(ch-C) 4.17 °C/W Channel to Ambient Thermal Resistance Rth(ch-A) 125 °C/W

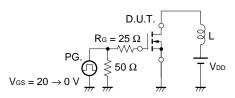
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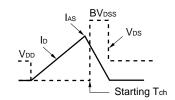


ELECTRICAL CHARACTERISTICS (TA = 25°C)

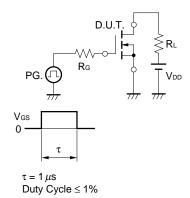
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	Vps = 100 V, Vgs = 0 V			10	μА
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 8 A	4.7	9.5		S
Drain to Source On-state Resistance	RDS(on)1	V _G S = 10 V, I _D = 8 A		100	125	mΩ
	RDS(on)2	Vgs = 4.5 V, Ib = 8 A		110	148	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		900		pF
Output Capacitance	Coss	V _G s = 0 V		110		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		50		pF
Turn-on Delay Time	td(on)	V _{DD} = 50 V, I _D = 8 A		9.0		ns
Rise Time	tr	V _G S = 10 V		5.0		ns
Turn-off Delay Time	t _{d(off)}	R _G = 0 Ω		30		ns
Fall Time	tf			4.0		ns
Total Gate Charge	Q _G	V _{DD} = 80 V		20		nC
Gate to Source Charge	Qgs	V _G s = 10 V		3.0		nC
Gate to Drain Charge	Q _{GD}	ID = 16 A		5.0		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 16 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 16 A, Vgs = 0 V		60		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		122		nC

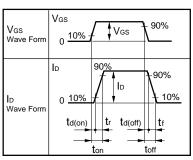
TEST CIRCUIT 1 AVALANCHE CAPABILITY





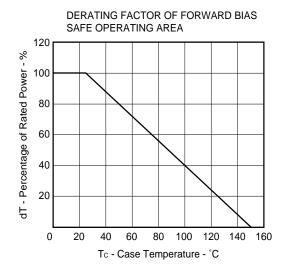
TEST CIRCUIT 2 SWITCHING TIME

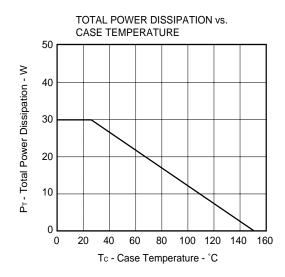




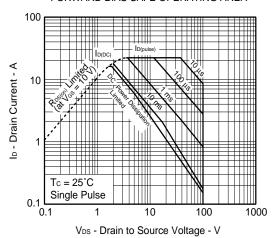
TEST CIRCUIT 3 GATE CHARGE

TYPICAL CHARACTERISTICS (TA = 25°C)

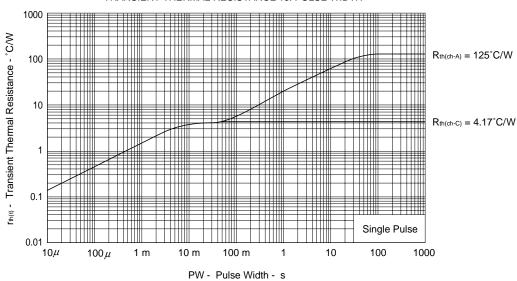




FORWARD BIAS SAFE OPERATING AREA

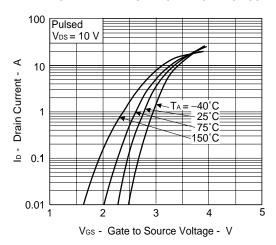


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

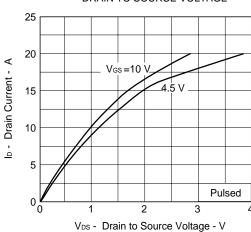


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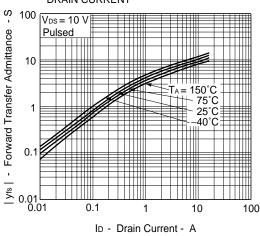
FORWARD TRANSFER CHARACTERISTICS



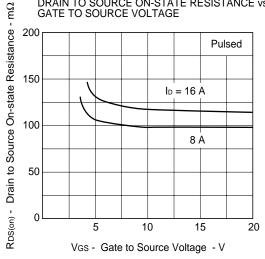
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



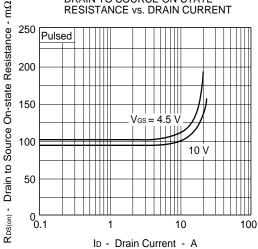
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



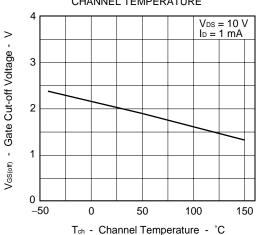
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



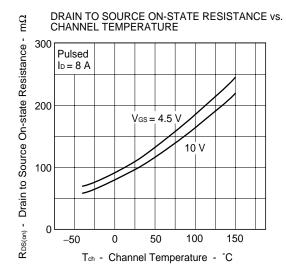
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

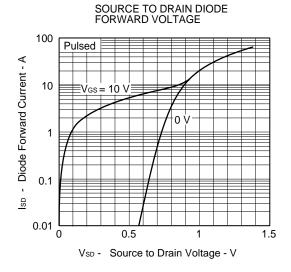


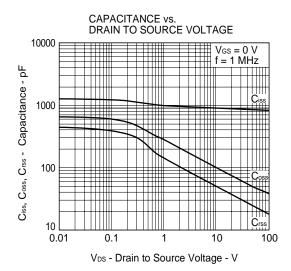
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

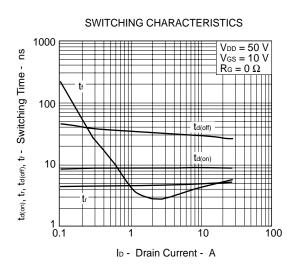


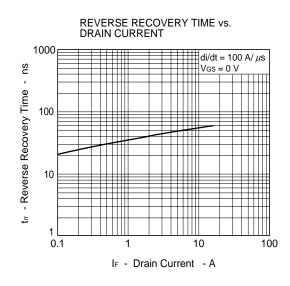


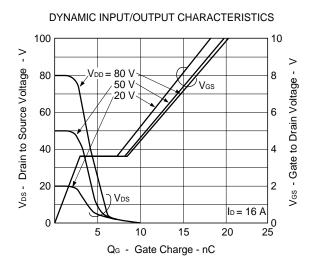


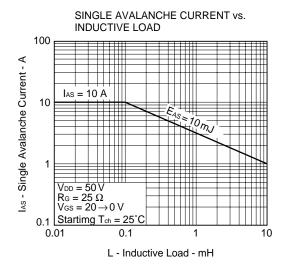


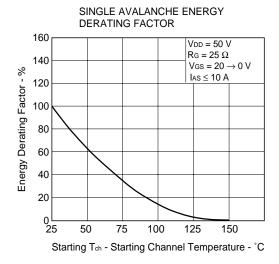








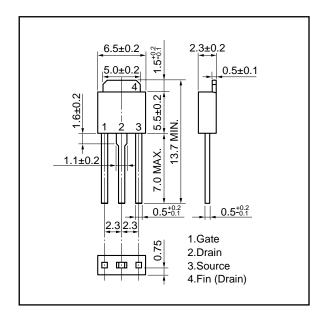




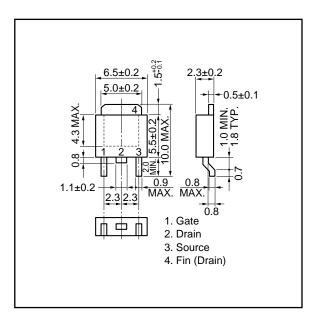


PACKAGE DRAWINGS (Unit: mm)

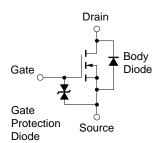
1) TO-251 (MP-3)



2) TO-252 (MP-3Z)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

7

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